Conduction Activation Energy in PEDOT:PSS Thin Films

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Abstract:

Conductive polymer PEDOT:PSS has been used for the fabrication of humidity and VOC sensors. The electrical conduction mechanism in this polymer is established, but the reported conduction activation energy (E_a) values vary in a wide range. Here, we report measuring E_a in different PEDOT:PSS samples and show that, indeed, E_a varies with the sample thickness and the relative humidity (RH) in the surrounding atmosphere. The results are explained by the assumption of multiple carrier excitation mechanisms. Three devices with different resistances at room temperature are constructed and the change in the device resistance is measured at different temperatures in environments with different RH levels. The results, surprisingly, indicates almost a linear relationship between the E_a and the RH; for every 5% increase in the RH, E_a increases by approximately 7%.

Key words: PEDOT:PSS, Relative humidity, electrical conduction mechanism, activation energy

Introduction

The excellent physical and chemical properties of conducting polymers make them attractive materials for electronic applications [1, 2]. One of the wellknown and widely used conducting polymers is poly(3,4-ethylenedioxythiophene):polystyrene sulphonate (PEDOT:PSS). The mechanism of charge transport in PEDOT:PSS films however, is yet to be fully understood. The most commonly accepted model is the variable range hopping (VRH) model, as proposed by Aleshin et al. [3]. Here, we investigate the effect of thickness and relative humidity on the conduction activation energy of PEDOT:PSS films measured in temperatures ranging from room temperature to 80 °C, and explain the obtained results by proposing the possibility of multiple carrier excitation mechanisms.

Experimental

The system used to perform the measurements is depicted in Fig. 1. It comprises a PEDOT:PSS film connected to golden electrodes at both ends. A signal generator is used to apply a predetermined sine-wave of 7 V amplitude and a frequency of 70 Hz to the sample causing current to flow through the series resistor. The voltage drop across the resistor is recorded and processed to obtain the sample resistance using a personal computer.

To construct the electrodes, a 200 nm film of gold of 99.9% purity is deposited via physical vapor deposition (PVD) in $10^{\text{-}5}$ torr vacuum on a slide of soda-lime glass. Thermal annealing is performed afterwards for 3 hours at 500 °C. The slides are then cut into 5x12 mm pieces using CO_2 laser. The gold in

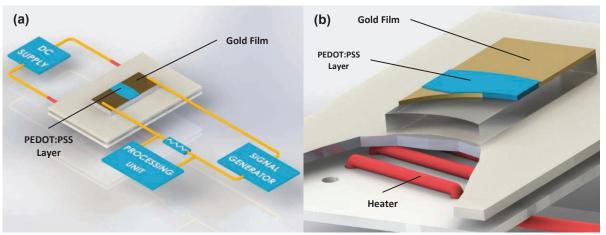


Fig. 1. (a) Schematic diagram of the fabricated device connected to the external measurement circuitry; (b) cross-sectional view of the system.

a 2x5 mm area, at the middle of the substrate surface of each chip is scratched away for PEDOT:PSS deposition. The cross-sectional view of the structure is demonstrated in Fig. 1b.

An aqueous solution of PEDOT:PSS prepared using PEDOT:PSS purchased from Sigma-Aldrich is drop casted on the glass slide using a 5 μ L sampler and left to dry on a heater. A microheater of Al-Fe-Cr wire is constructed underneath the chip allows controlled heating of the sample during the experiments. Prior to each experiment the humidity of the measurement chamber is monitored using a standard hygrometer and adjusted by injection of dry air.

Results

PEDOT:PSS films of various thicknesses with resistances of 1.8, 23 and 35 M Ω are tested for temperature dependence of their resistances at two different RH levels. The samples are heated slowly from room temperature to 80 °C and the sample's resistance is measured and recorded at equal temperature intervals. The experiment is performed in both an environment of 25 % relative humidity, as well as a dry atmosphere. Results are presented in Fig. 2.

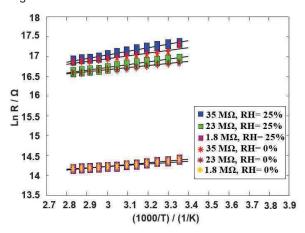


Fig. 2. The change in PEDOT:PSS film resistance with temperature measured in two different RH levels

The activation energy in each case is obtained from the slope of the graph, according to Arrhenius's equation:

$$R = R_0 \exp(\frac{E_a}{kT}) \tag{1}$$

Where R is the sample's resistance at the absolute temperature T, k is Boltzmann's constant, and R_0 is a

Tab. 1: Activation energy for PEDOT:PSS films of different resistances in dry and humid atmospheres

Sample resistance / MΩ	Activation Energy (eV)	
	RH = 0%	RH = 25%
1.8	0.03	0.04
23	0.04	0.06
35	0.06	0.08

constant. Table 1 gives the activation energies derived from Fig. 2 for the three samples in both environments.

As can be seen, activation energy decreases with sample thickness. This is because a thicker sample provides more available states for the electric charges to hop to.

Water molecules in air are absorbed by the PEDOT:PSS molecules as demonstrated in Fig. 3, thereby blocking some of the available transport sites for the carriers, which explains the decrease in activation energy with humidity.

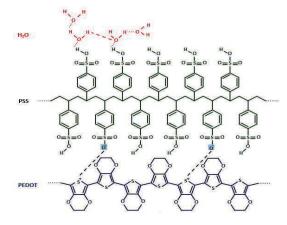


Fig. 3. The molecularl structure of PEDOT:PSS and possible H₂O absorption sites.

Conclusion

The conduction activation energy in PEDOT:PSS films decreases with thickness. For a constant thickness, however, the activation energy increases with the RH at the surrounding atmosphere. The former effect is owing to the higher number of available hopping sites for an electron in a thicker sample, and the latter effect, on the other hand, is due to the site blockage caused by the adsorbed water molecules.

References

- [1] Hossein-Babaei, Faramarz, and Ali Hooshyar Zare. "The selective flow of volatile organic compounds in conductive polymer-coated microchannels." Scientific Reports 7 (2017): 42299. DOI: 10.1038/srep42299
- [2] Hossein-Babaei, Faramarz, and Pejman Shabani. "A gold/organic semiconductor diode for ppm-level humidity sensing." Sensors and Actuators B: Chemical 205 (2014): 143-150. DOI: doi.org/10.1016/j.snb.2014.08.061
- [3] Aleshin, A. N., S. R. Williams, and A. J. Heeger. "Transport properties of poly (3, 4-ethylenedioxythiophene)/poly (styrenesulfonate)." Synthetic Metals 94.2 (1998): 173-177. DOI: doi.org/10.1016/S0379-6779(97)04167-2